Notice of References Cited Application/Control No. 10/539,254 Examiner Reexamination MIYAKE ET AL. Art Unit Ram N. Kackar 1763 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0021422	09-2001	Yamakoshi et al.	427/569
*	В	US-2002/0023718	02-2002	Choi et al.	156/345
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	н	US-		,	
	-	US-			
	J	US-			
	К	US-			
	L	US-		7.13,13	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001094485 A	04-2001	Japan	NAKAMURA et al.	
	0	JP 08162291 A	06-1996	Japan	OKU, KOJI	
	Р					
	α	111111111111111111111111111111111111111				
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.